

QUERY CONTROL FORM				RTIS USE ONLY	
Application No.	09986137	Prepared by	EWC	Tracking Number	05878275
Examiner-GAU	Lee	Date	2/11/04	Week Date	12-22-03
	2881	No. of queries	- 1 -		IFW

## JACKET

- |                      |                        |                    |                |
|----------------------|------------------------|--------------------|----------------|
| a. Serial No.        | f. Foreign Priority    | k. Print Claim(s)  | p. PTO-1449    |
| b. Applicant(s)      | g. Disclaimer          | l. Print Fig.      | q. PTOL-85b    |
| c. Continuing Data   | h. Microfiche Appendix | m. Searched Column | r. Abstract    |
| d. PCT               | i. Title               | n. PTO-270/328     | s. Sheets/Figs |
| e. Domestic Priority | j. Claims Allowed      | o. PTO-892         | t. Other       |

## SPECIFICATION

- a. Page Missing
- b. Text Continuity
- c. Holes through Data
- d. Other Missing Text
- e. Illegible Text**
- f. Duplicate Text
- g. Brief Description
- h. Sequence Listing
- i. Appendix
- j. Amendments
- k. Other

## MESSAGE

(1) PTO-1449 Please either initial or line through citations. See attached  
 (2) Specification and other 1449 forms are illegible  
 Please provide clear copy

THANK YOU

EWC

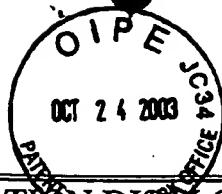
## CLAIMS

- a. Claim(s) Missing
- b. Improper Dependency
- c. Duplicate Numbers
- d. Incorrect Numbering
- e. Index Disagrees
- f. Punctuation
- g. Amendments
- h. Bracketing
- i. Missing Text
- j. Duplicate Text
- k. Other

initials

## RESPONSE

initials



SHEET 1 OF 1

<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  <b>(PTO-1449)</b>				ATTY. DOCKET NO. 49959-220	SERIAL NO. 09/986,137
				APPLICANT Gilad ALMOGY, et al.	
				FILING DATE November 07, 2001	GROUP 2881
U.S. PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	US	5,080,603	02/25/92	Ames et al.	
	US	5,239,178	08/24/93	Derndinger et al.	
	US	4,500,202	02/19/85	Smyth	
	US	3,983,354	06/15/76	Feldman et al.	
	US	5,196,800	03/23/93	Petersen	
	US	6,108,090	08/22/00	Ishihara	
	US	5,783,833	07/21/98	Sugaya et al.	
	US	6,208,411	03/27/01	Vaez-Iravani	
	US				
FOREIGN PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number +-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear
		EP 1058111 A2	12/06/00	Europe	
		WO 87/34171	09/18/87	PCT	
		WO 89/48041	09/23/99	PCT	
		EP 1138254 A1	10/04/01	Europe	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)					
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
		"Quality control and process observation for the micro assembly process", Tilo Pfeifer et al, MEASUREMENT, INSTITUTE OF MEASUREMENT AND CONTROL; vol. 30, no. 1, July 2001, pp. 1-18.			
EXAMINER			DATE CONSIDERED		

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809. Draw line through citation if not in conformance and not considered.  
Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.